

SURF III

Calibration capabilities

Synchrotron radiation research since 1963.

NIST

National Institute of Standards and Technology • U.S. Department of Commerce

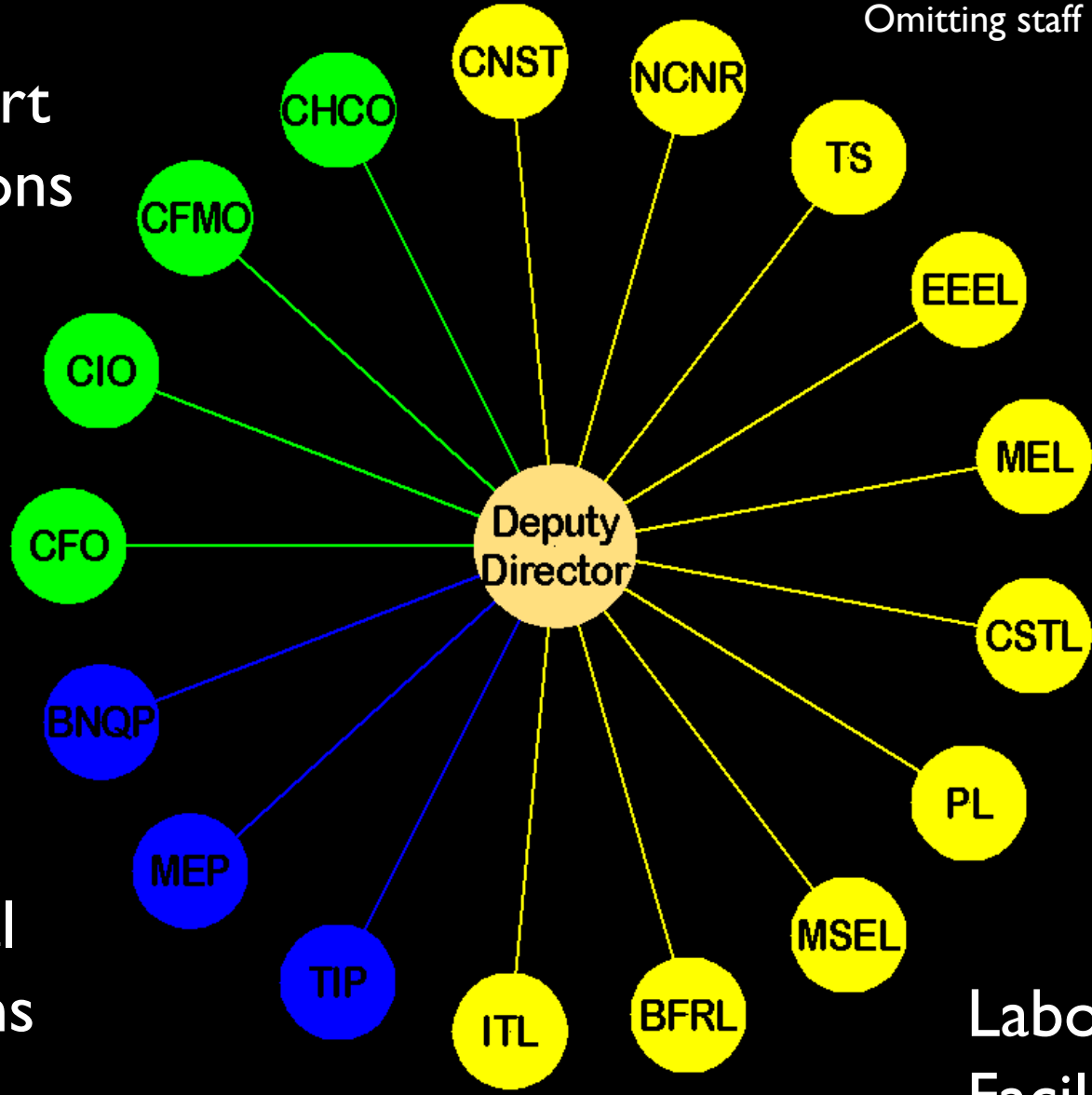
Outline

- NIST Reorganization
- Physical Measurement Laboratory
- Synchrotron light: What is and why is it useful?
- Basic properties of synchrotron light at SURF
- Absolute source- and detector-based radiometry
- SURF
- Calibrations on Beamline 2
- Transfer of X24C from NSLS to SURF

NIST at the beginning of 2010

Omitting staff offices/functions

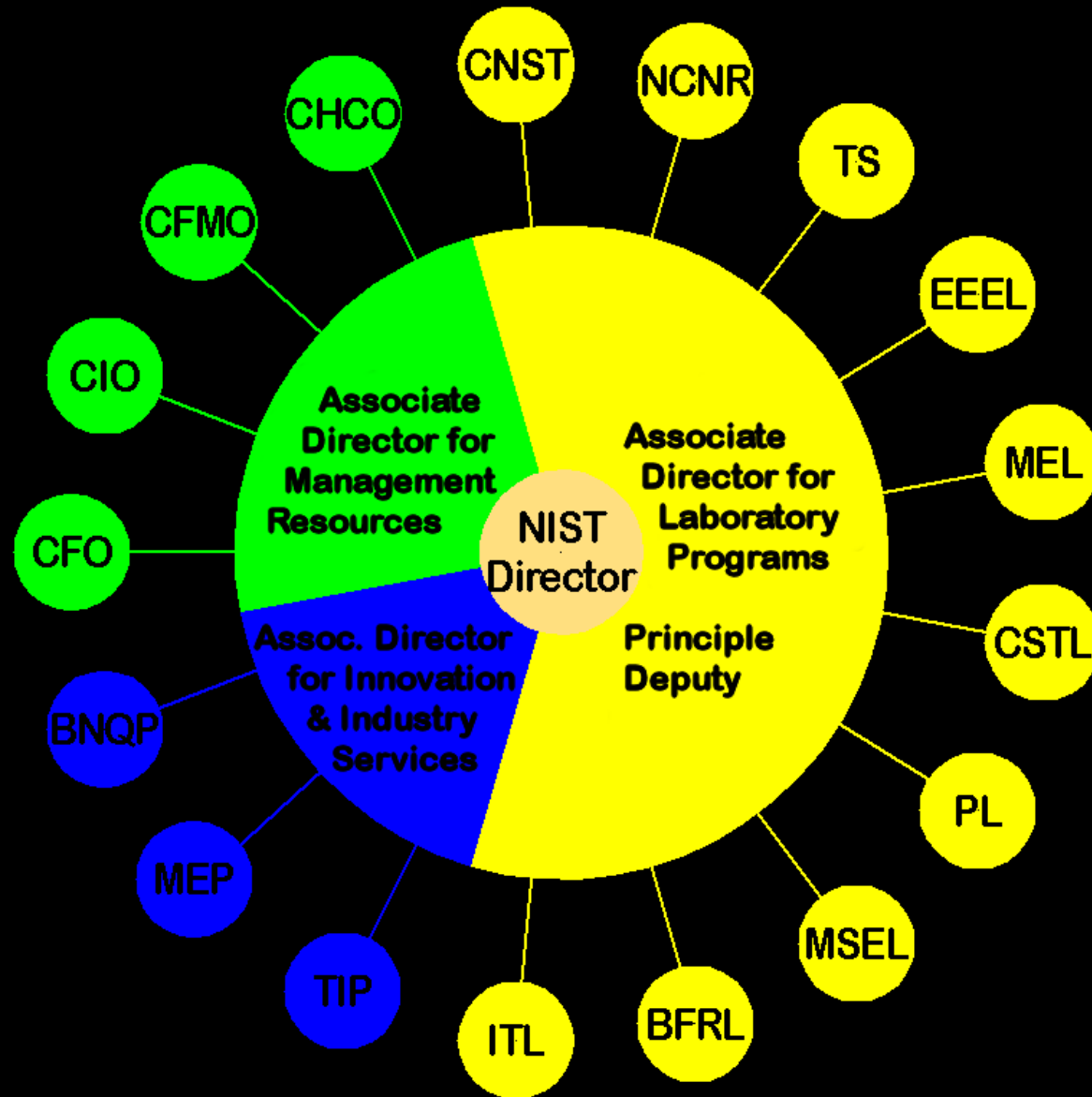
Support
Functions



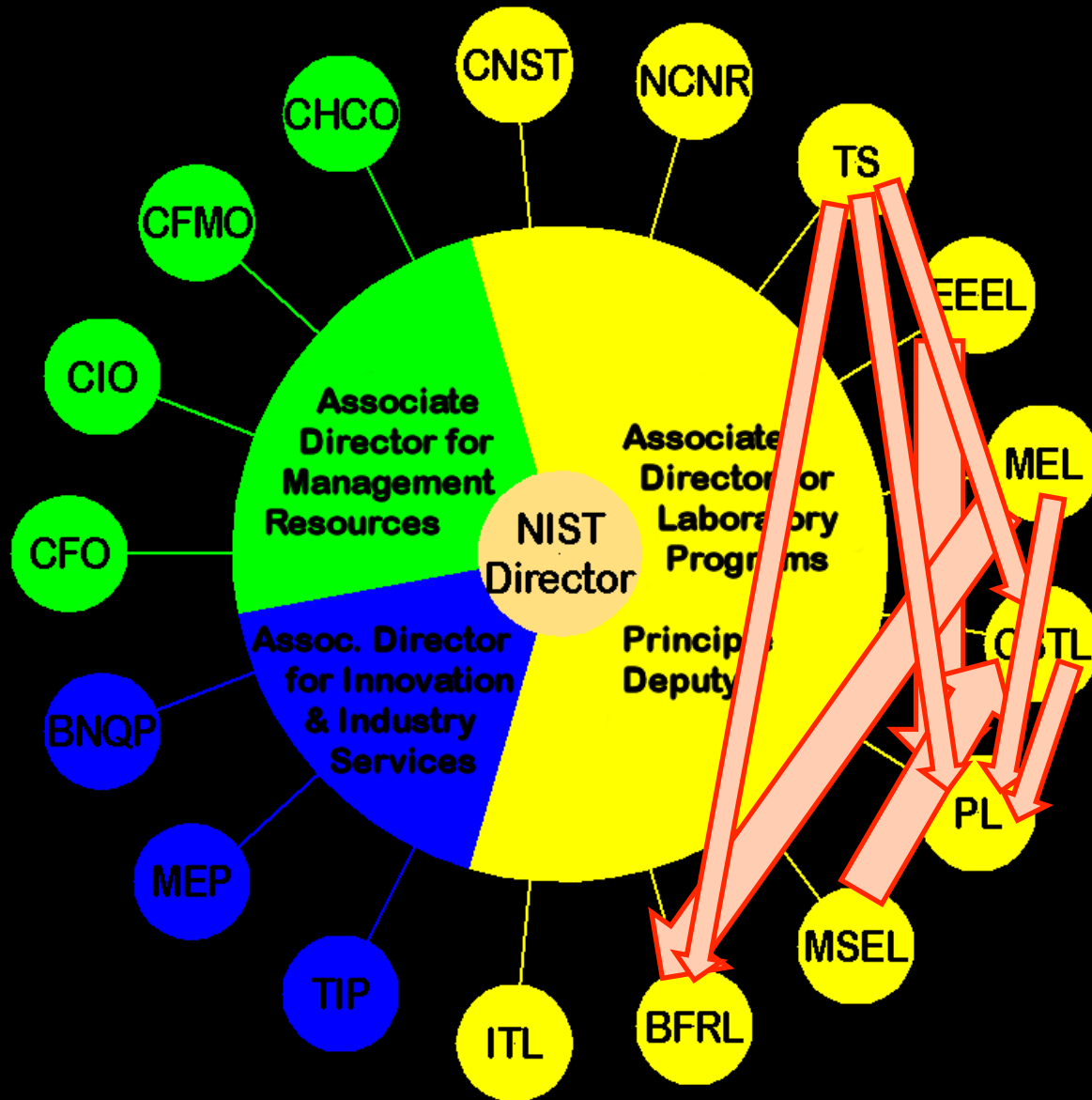
External
Programs

Laboratories &
Facilities

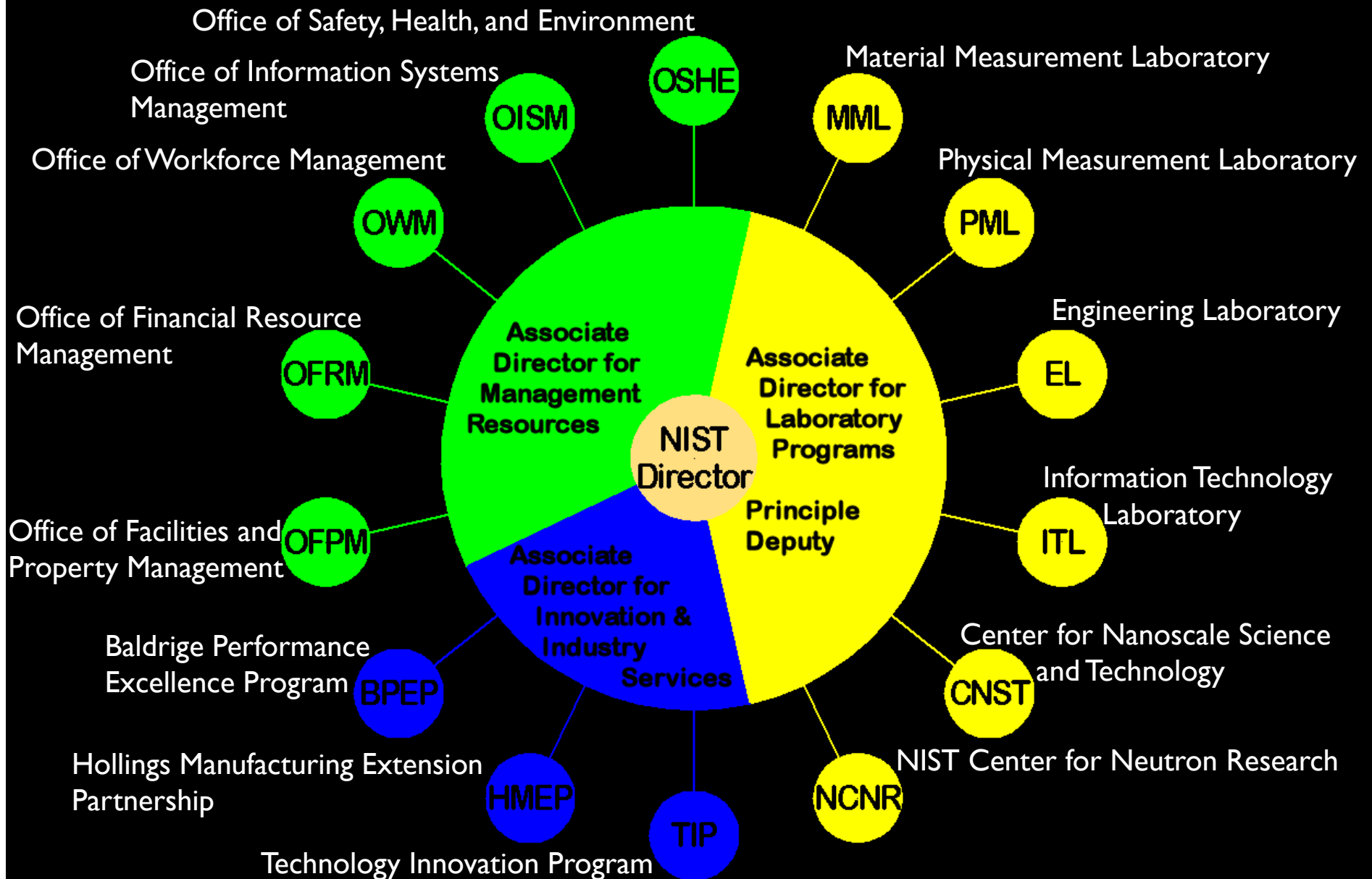
NIST Summer 2010



NIST Summer 2010



NIST Fall 2010



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Physics Lab, September 30th, 2010

Lab Office

Atomic Physics

Physics

Electron &
Optical Physics

Physics

Ionizing
Radiation

Physics

Optical
Technology

Physics

Quantum Physics

Physics

Time and
Frequency

Physics

Physical Measurement Lab, October 1, 2010

Lab Office

Atomic Physics

Physics

Electromagnetics

Electronics and
Electrical Engineering

Electron &
Optical Physics

Physics

Ionizing
Radiation

Physics

Mechanical
Metrology

Mechanical
Engineering

Optical
Technology

Physics

Optoelectronics

Electronics and
Electrical Engineering

Quantum Electrical
Metrology

Electronics and
Electrical Engineering

Quantum Physics

Physics

Semiconductor
Electronics

Electronics and
Electrical Engineering

Temperature,
Pressure & Flow
Metrology

Chemical Science and
Technology

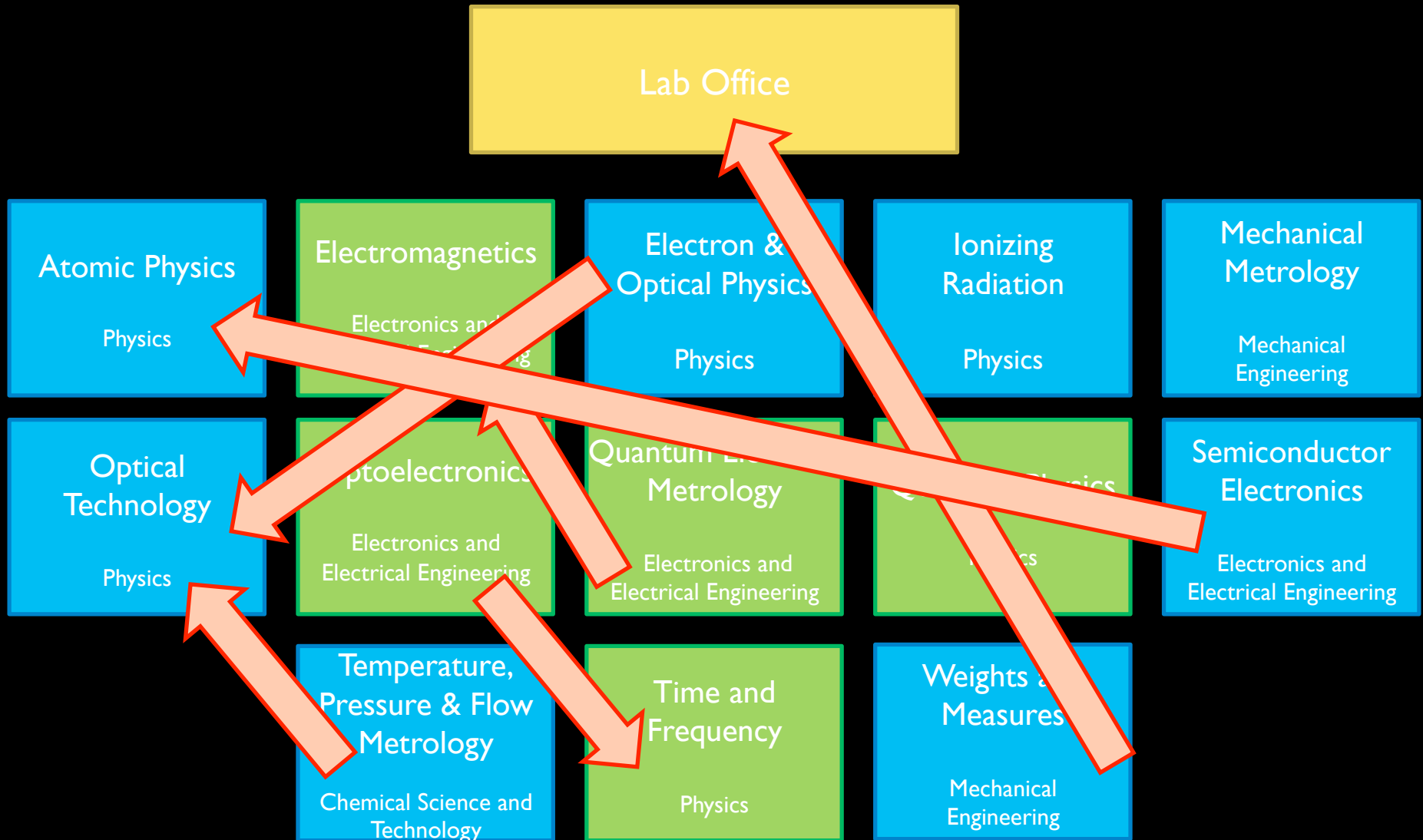
Time and
Frequency

Physics

Weights and
Measures

Mechanical
Engineering

Physical Measurement Lab, October 1, 2011



PML Organized into Eight Divisions

PML Office

Boulder Labs Director Office
Office of Weights & Measures
National Voluntary Laboratory Accreditation Program (NVLAP)

Semiconductor & Dimensional Measurement

Dimensional and surface metrology (e.g., length, roughness)
Microscopy (e.g., optical, electron, atomic force)
Semiconductor manufacturing applications, and reliability

Quantum Electronics and Photonics Division

Quantum devices
Radiometry and detectors
Nanophotonic metrology

Quantum Measurement Division

Atomic physics, spectroscopy, and quantum information
Electrical measurements based on quantum standards
Mass and force measurements

Electromagnetics Division

Radio-frequency electronics
Radio-frequency fields
Magnetics

Sensor Science Division

Temperature, humidity, pressure, vacuum, flow
Photometry and radiometry (from far infrared to soft x-ray)
Optical radiation standards and measurement methods

Time and Frequency Division

Standards for civil timekeeping
Frequency standards
Quantum Information with ion qubits

Radiation and Biological Physics Division

Biophysics and molecular imaging
Medical imaging and radiation dosimetry
Standards for radioactivity and neutron dosimetry

Quantum Physics Division

NIST at JILA
Advances the frontiers of measurement science
in partnership with the University of Colorado

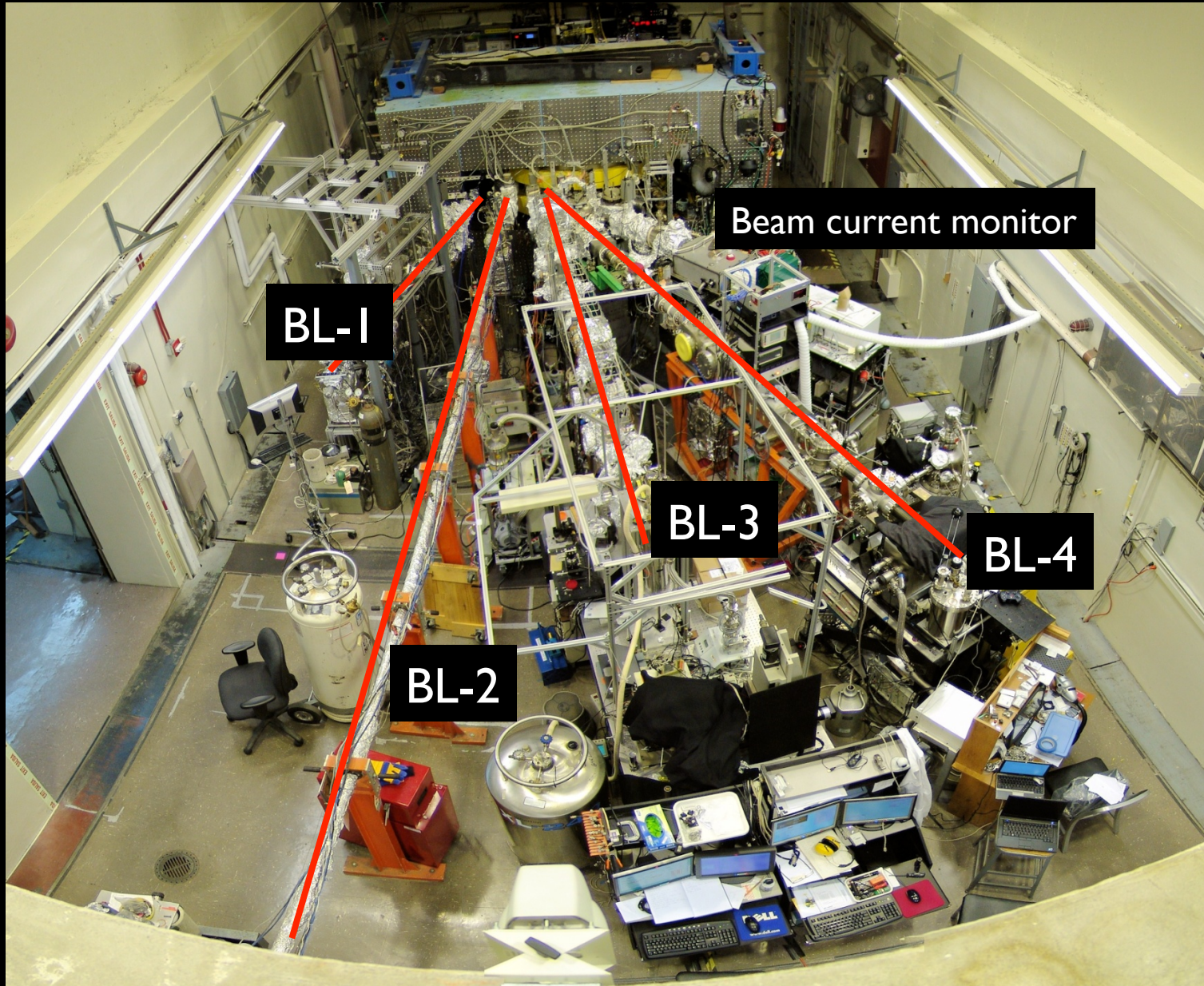
Synchrotron Ultraviolet Radiation Facility

- What does this mean for SURF?
 - Electron & Optical Physics Division has been disbanded
 - Far UV Physics and Photon Physics Groups are combined
 - The new Ultraviolet Radiation Group is part of the Sensor Science Division (former Optical Technology Division, Chief Gerald Fraser)
- Charles Clark is not Division Chief anymore, he is now a NIST fellow
- Tom Lucatorto is Group Leader

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Synchrotron Ultraviolet Radiation Facility

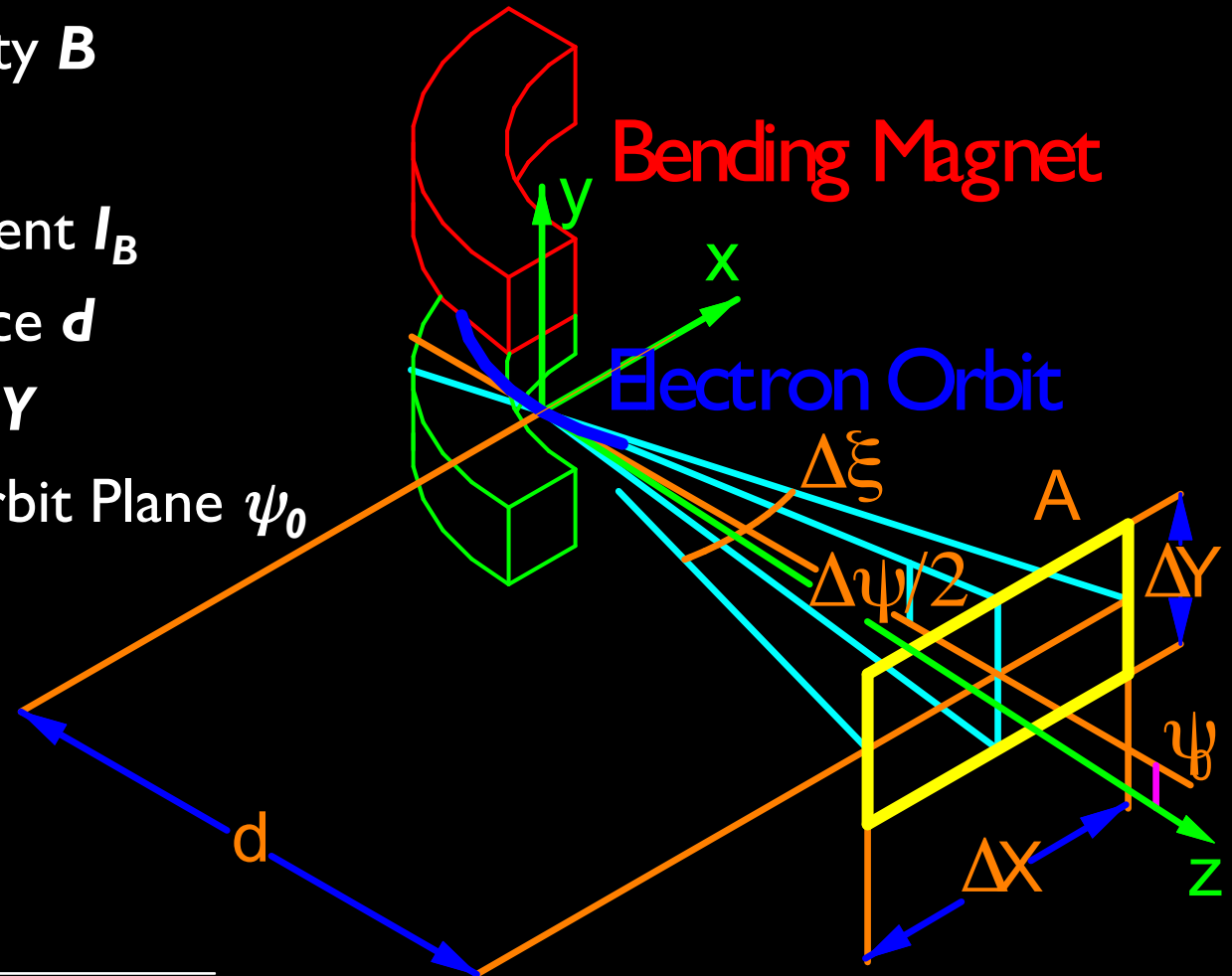


Why is Synchrotron Radiation useful?

- Electromagnetic radiation emitted by highly relativistic electrons or positrons bend onto an orbit by magnets (**Magneto-Bremsstrahlung**).
- Emitted spectrum: **broadband** from microwave (harmonics of driving RF field) to x-rays, **highly collimated, polarized, calculable**.
- Output scales with **electron beam current**.
- Extremely **clean lightsource** operated in oil-free vacuum, which avoids photo-activated polymerization of hydrocarbons.
- Synchrotron radiation provides an **absolute source!**

SURF as an Absolute Source

- Magnetic Flux Density B
- Radio-frequency ν_{rf}
- Electron Beam Current I_B
- Source Point Distance d
- Aperture Size $\Delta X, \Delta Y$
- Angle Relative to Orbit Plane ψ_0



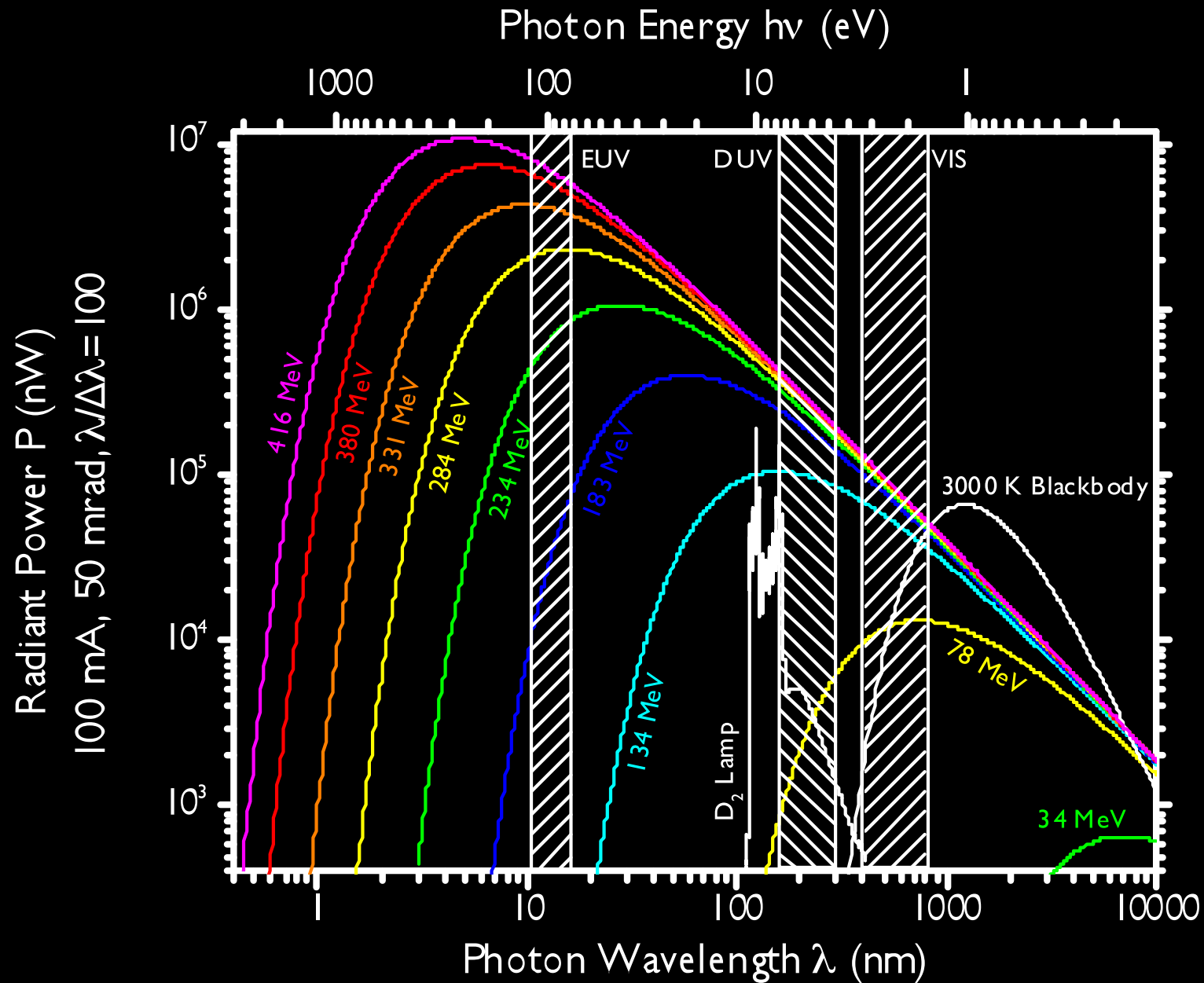
$$\rho = \frac{E \beta}{e_0 B c} = \sqrt{\left(\frac{c}{\pi \cdot \nu_{rf}}\right)^2 - \left(\frac{m_e \cdot c}{B \cdot e_0}\right)^2}$$

$$\gamma = \frac{E}{m_e c^2} = \frac{B \cdot e}{\pi \cdot \nu_{rf} \cdot m_e} \approx 744 @ 380 \text{ MeV}$$

Outline

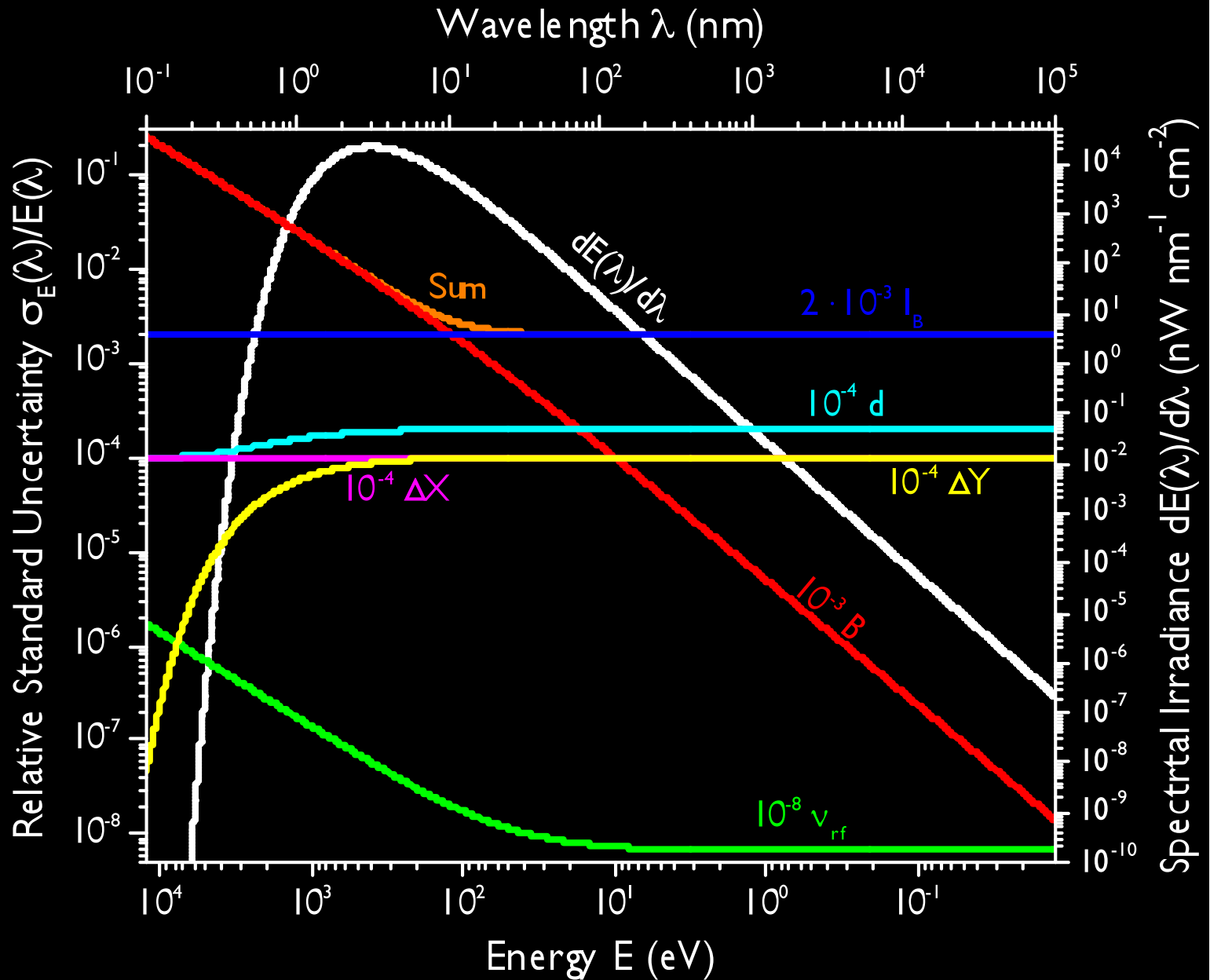
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Custom-Tailored Output Spectrum

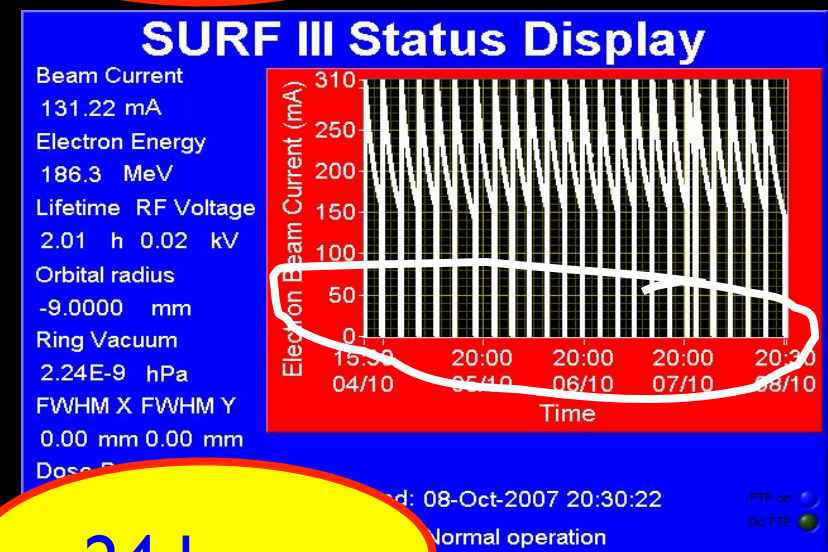
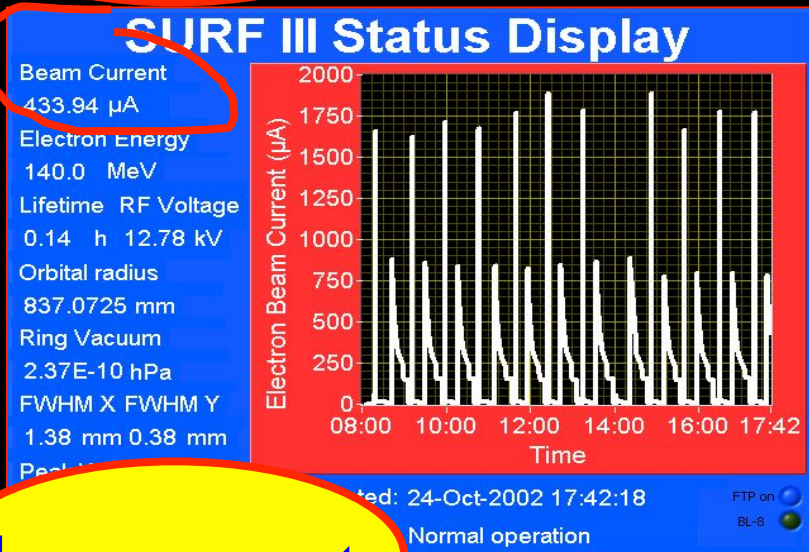
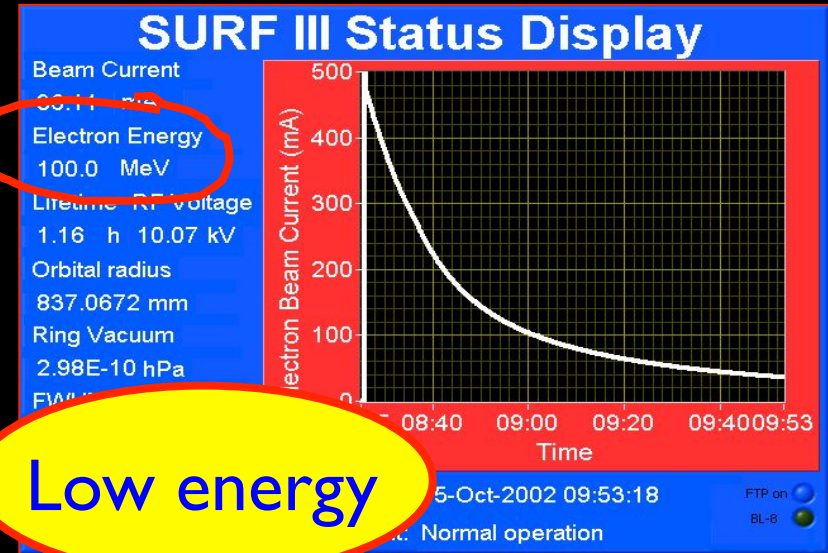
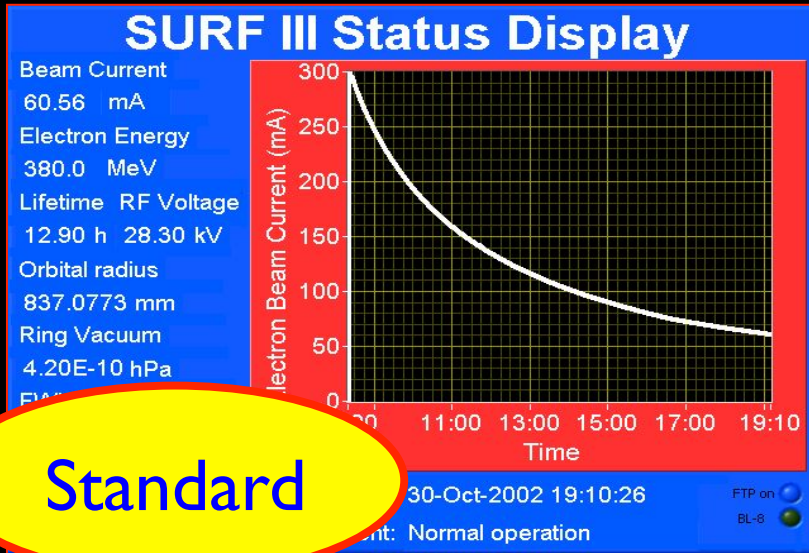


Absolute Source Uncertainty

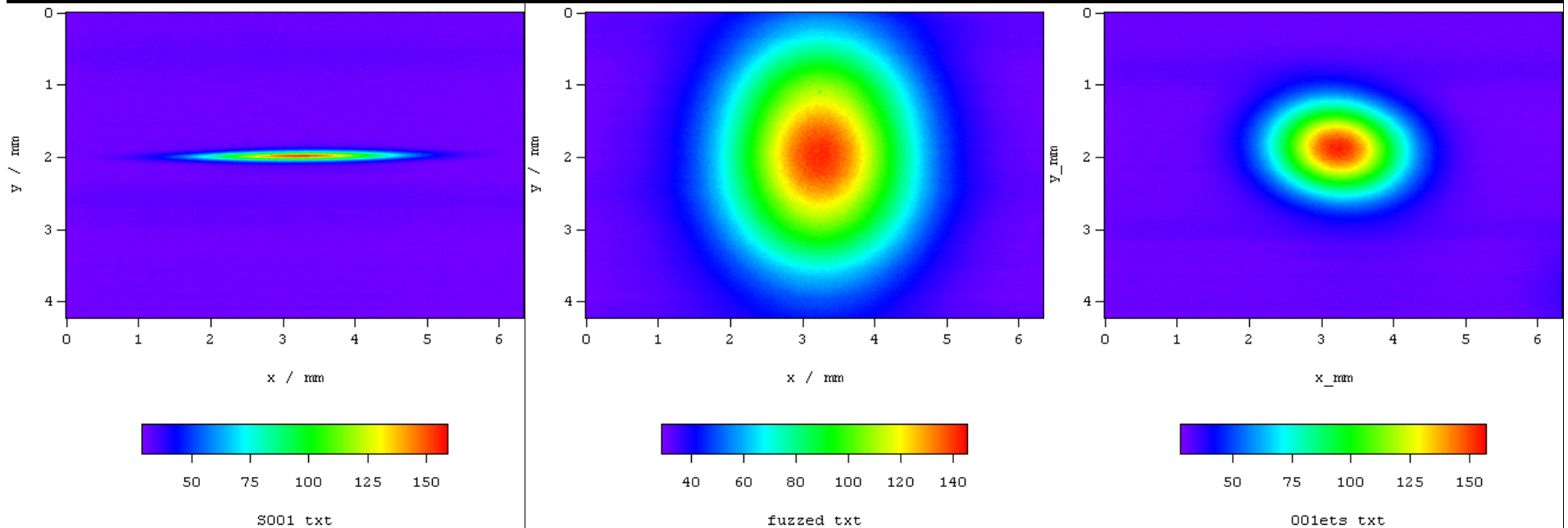
$E=380$ MeV
 $B=1.5142$ T
 $\nu_{rf}=114$ MHz
 $I_B=1$ mA
 $d=10000$ mm
 $\Delta X=7.071$ mm
 $\Delta Y=7.071$ mm



Flexibility in Operation



Flexibility in Beam Size



No fuzz

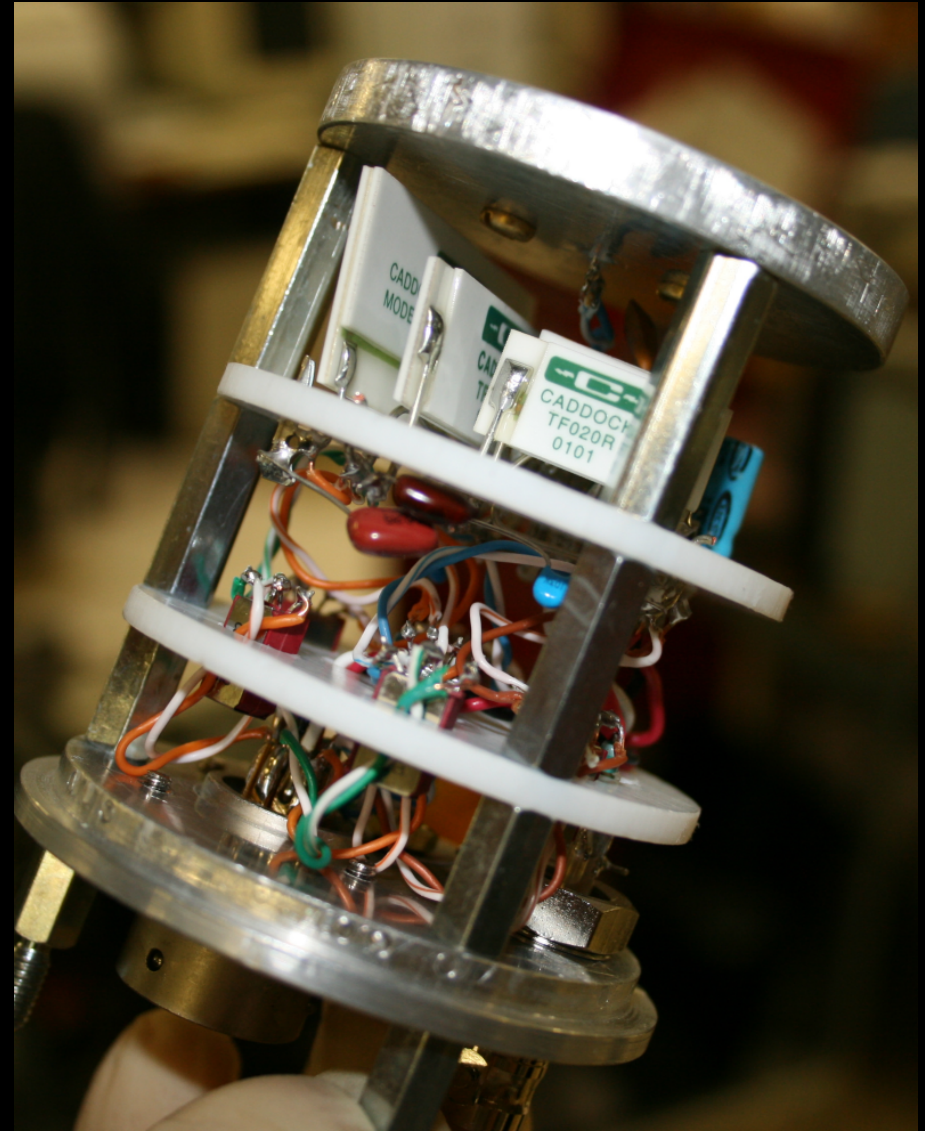
12 W fuzz

Full coupling

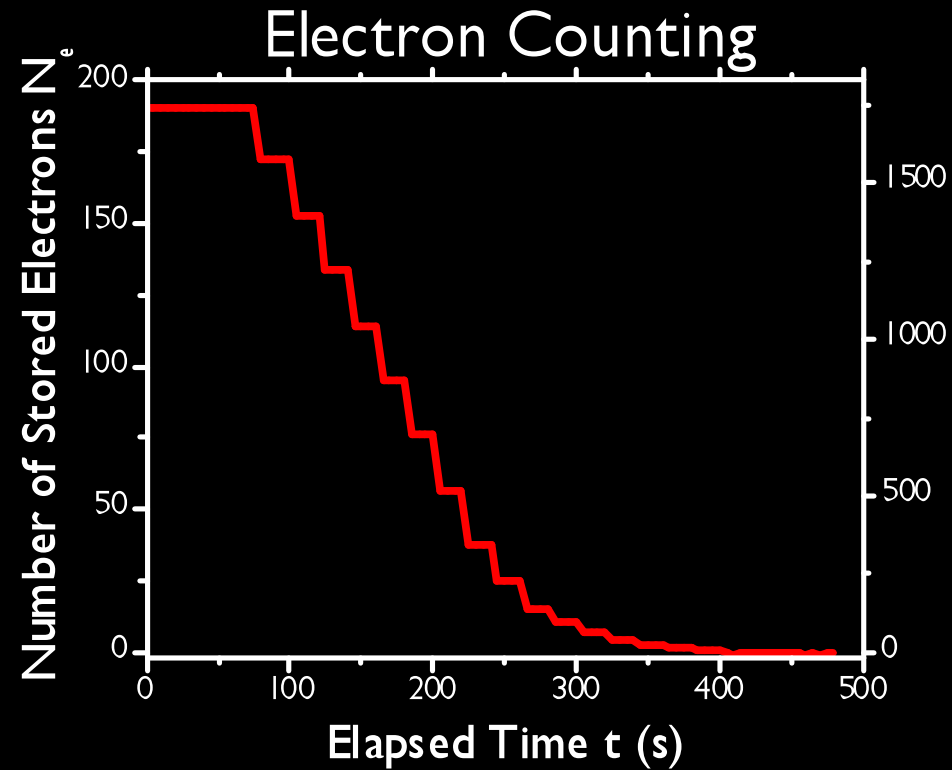
	σ_y (mm)	σ_x (mm)
No fuzz	0.042	0.889
Full fuzz	1.202	0.914
Full coupling	0.440	0.636

SURF Electron Beam Current Monitor

- Beam current is measured optically using **ND filter** + **Si diode** + **operational amplifier** (Eppeldauer and Hardis, *Appl. Opt.* **30** (22), 3091-9 (1991)). Relative standard uncertainty 0.2 %.
- System is linear over **11 orders of magnitude**. Extrapolate from the light from a single electron to that of 10^{11} electrons.

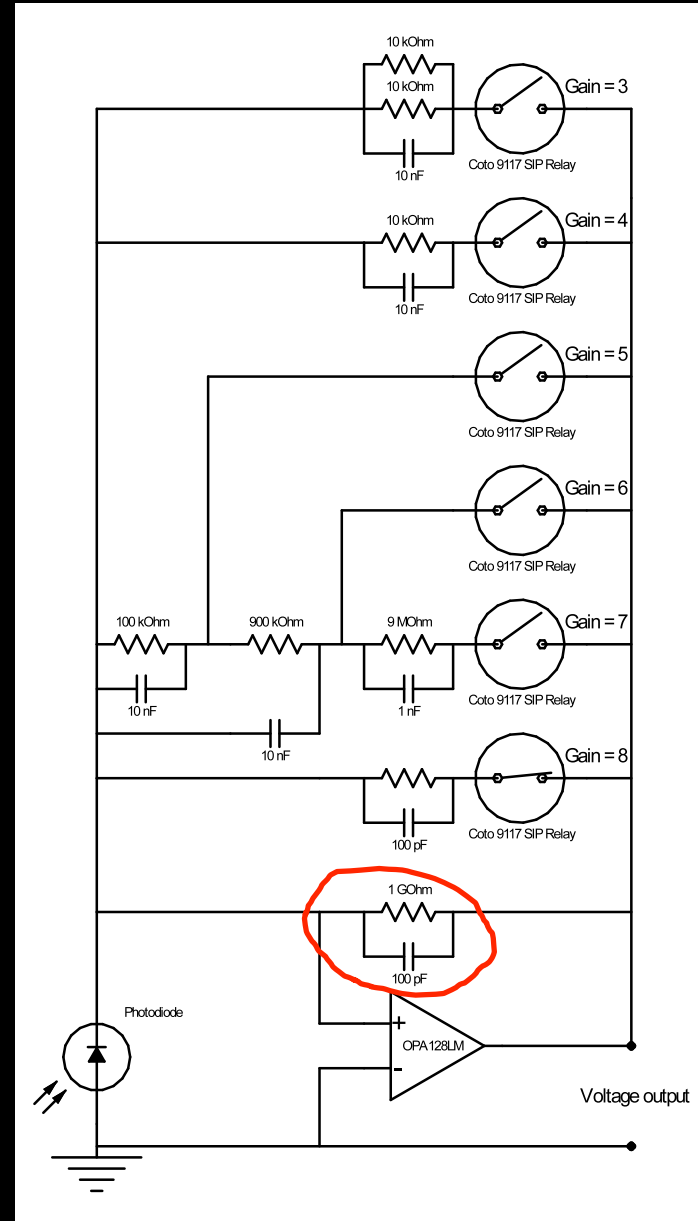


Electron Counting



Hughey and Schaefers
Nucl. Instrum. & Meth. 195,
367 (1982)

Stored Electron Beam Current I_B (pA)

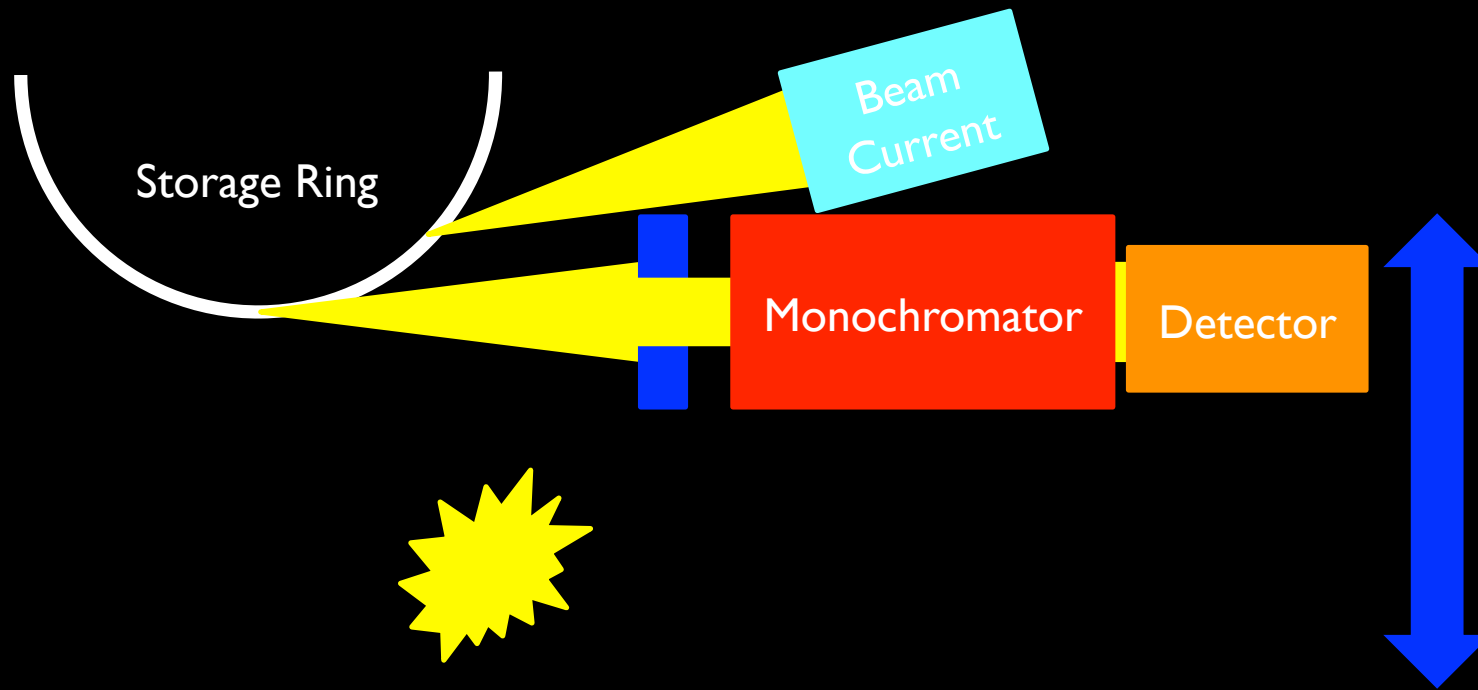


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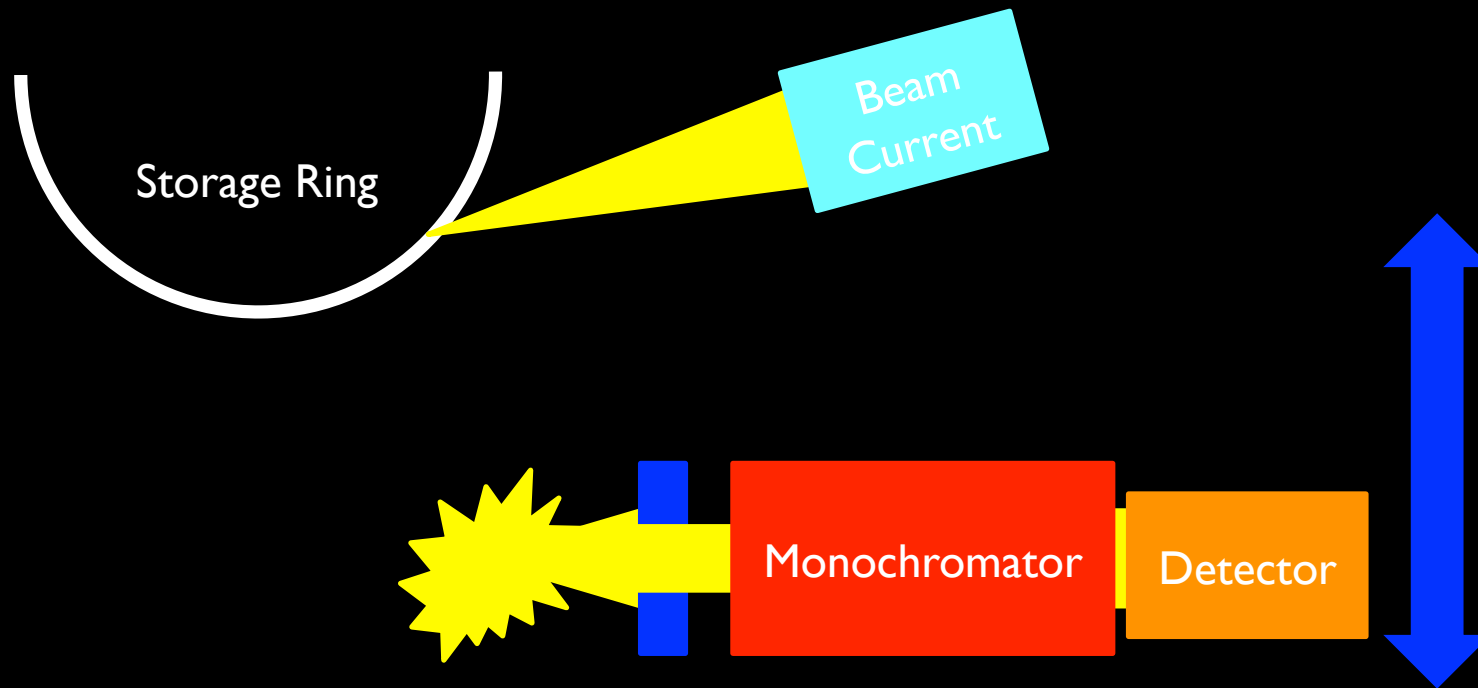
Absolute Radiometry: Source Based

Absolute source based Radiometry: Calibrate different standard sources, spectrometers



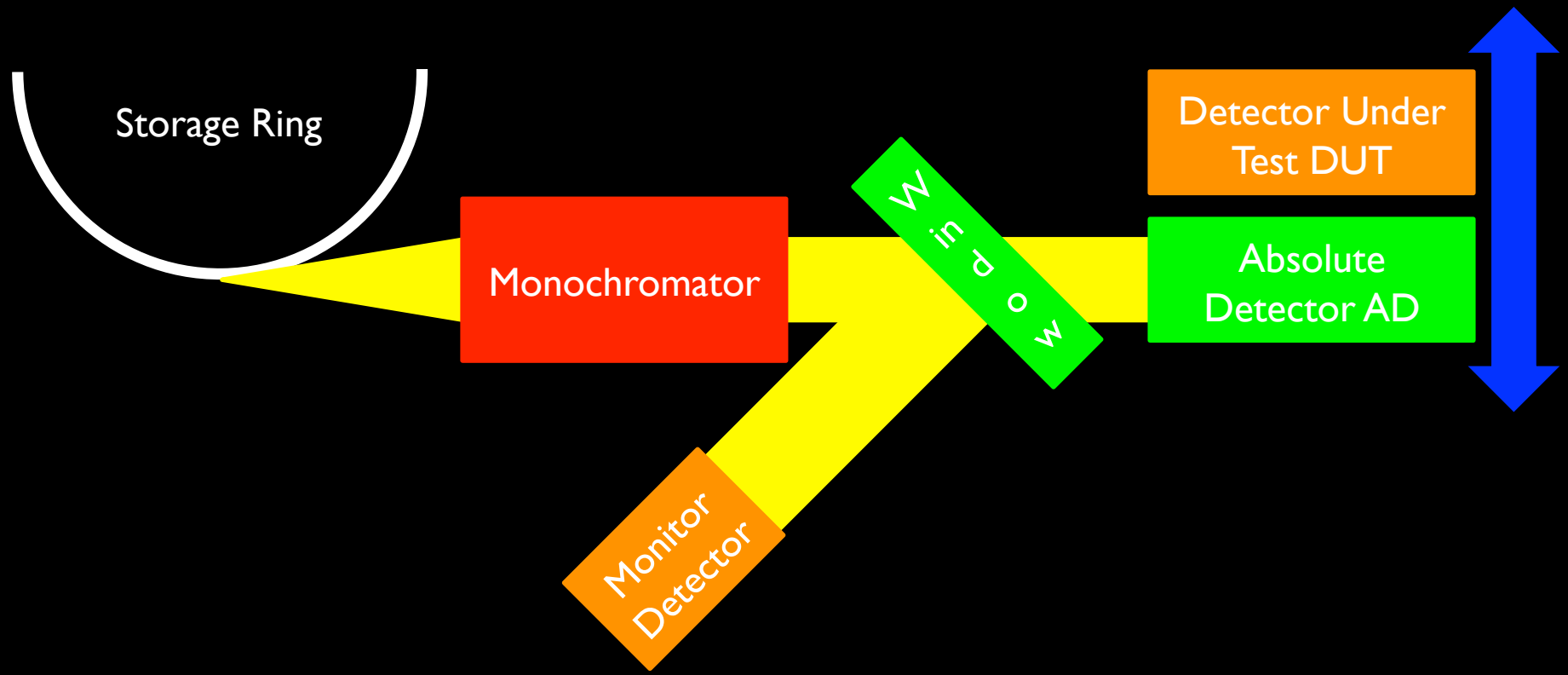
Absolute Radiometry: Source Based

Absolute source based Radiometry: Calibrate different standard sources, spectrometers



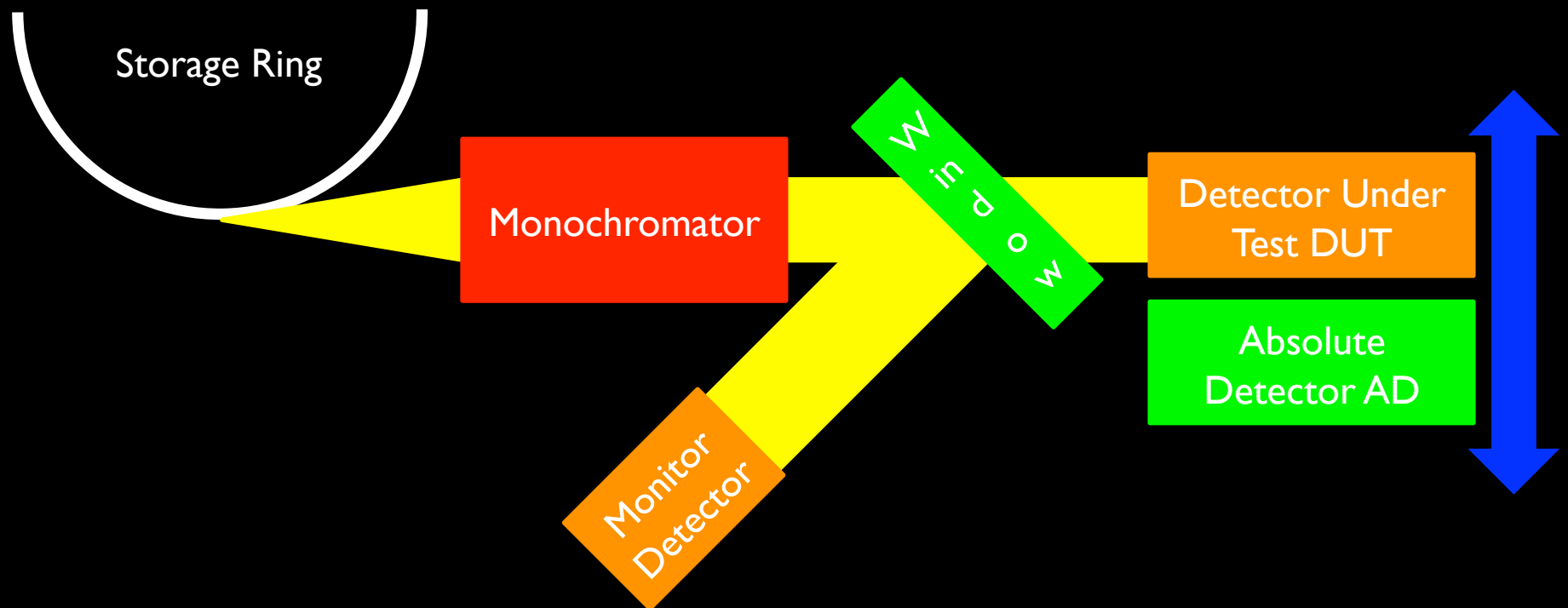
Absolute Radiometry: Detector Based

Absolute Detector based Radiometry: Calibration of detectors, filter detector packages

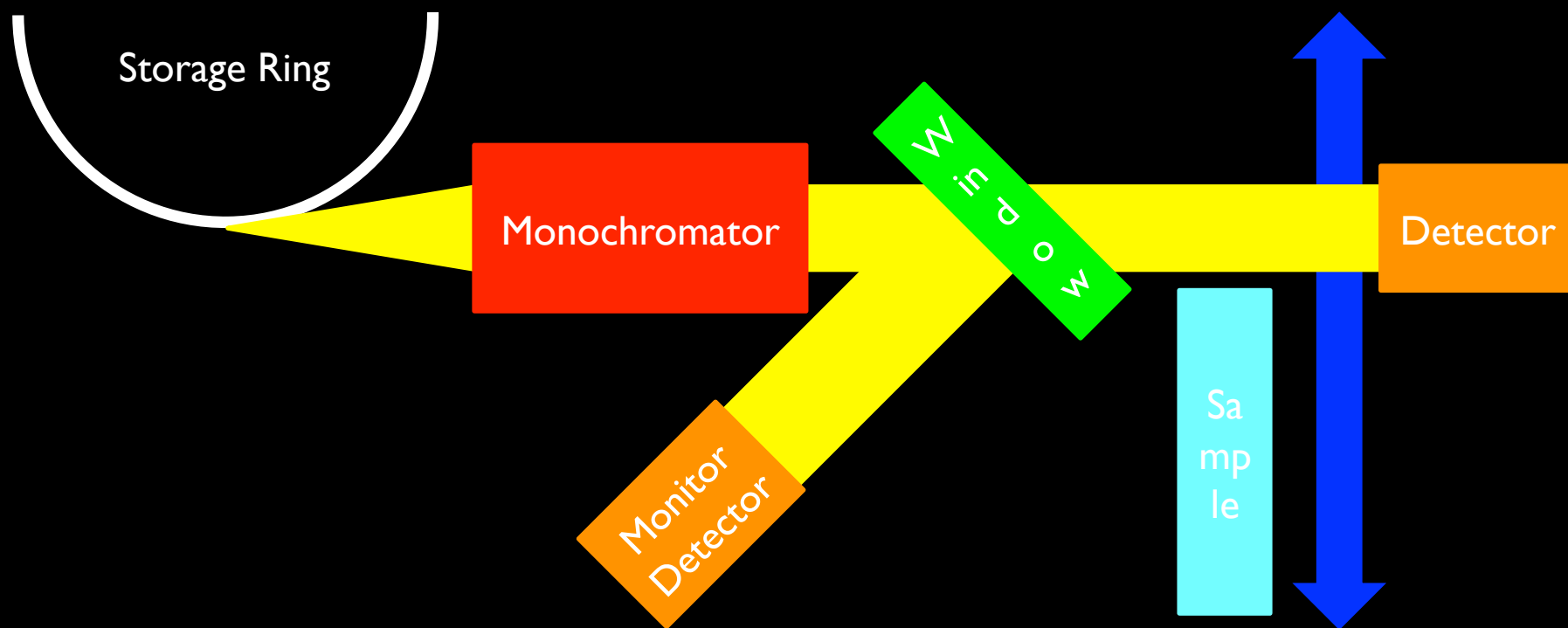


Absolute Radiometry: Detector Based

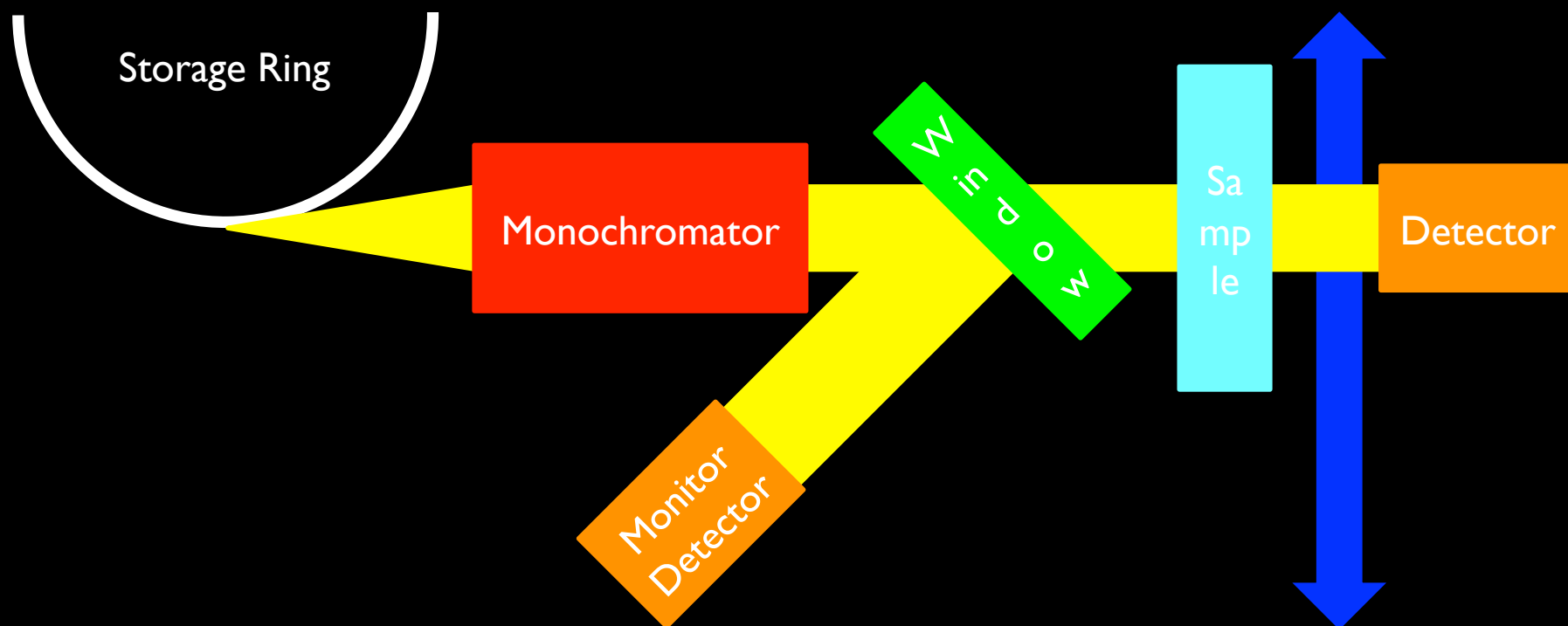
Absolute Detector based Radiometry: Calibration of detectors, filter detector packages



Transmission Measurement



Transmission Measurement



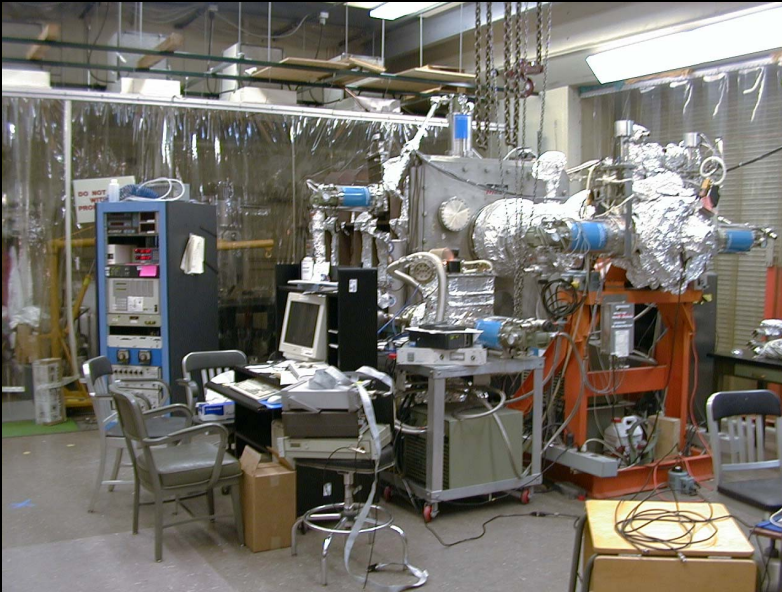
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Beamlines at SURF III/NIST

#	Wavelength range	Calibration	Accuracy
1a	13 nm	Resist sensitivity (EUV)	
1b	5 nm – 20 nm	Photoresist prequalification testing (EUV) Optics lifetime (EUV)	
2	0.3 nm - 400 nm	EUV/UV spectrometer calibrations	<1.0 %
3	200 nm – 400 nm 200 nm – 2000 nm	Light sources (D ₂ and other UV) Filtered radiometers (UV,VIS, NIR)	<1.0 % <0.5 %
4	140 nm - 320 nm (110 nm – 320 nm)	Detector calibrations (DUV, UV) Detector radiation damage (DUV, UV) Optical properties (DUV, UV)	< 0.5 % (AXUV) < 1.0 % < 1.0 %
5	100 nm - 400 nm	Index measurements (DUV)	< 0.0001 %
6		Beam Current Monitor	0.2 %
7	7 nm - 35 nm	Reflectometry (EUV) Optical properties (EUV) Detector calibrations (EUV)	< 1 % < 1 % < 2 %
8	13 nm	Optics lifetime(EUV) EUV-induced surface chemistry	
9	5 nm - 50 nm	Detector calibrations (EUV)	< 5 %
10	550 nm	Beam imaging	< 5 %

BL-2: UV/EUV Spectrometer Calibrations



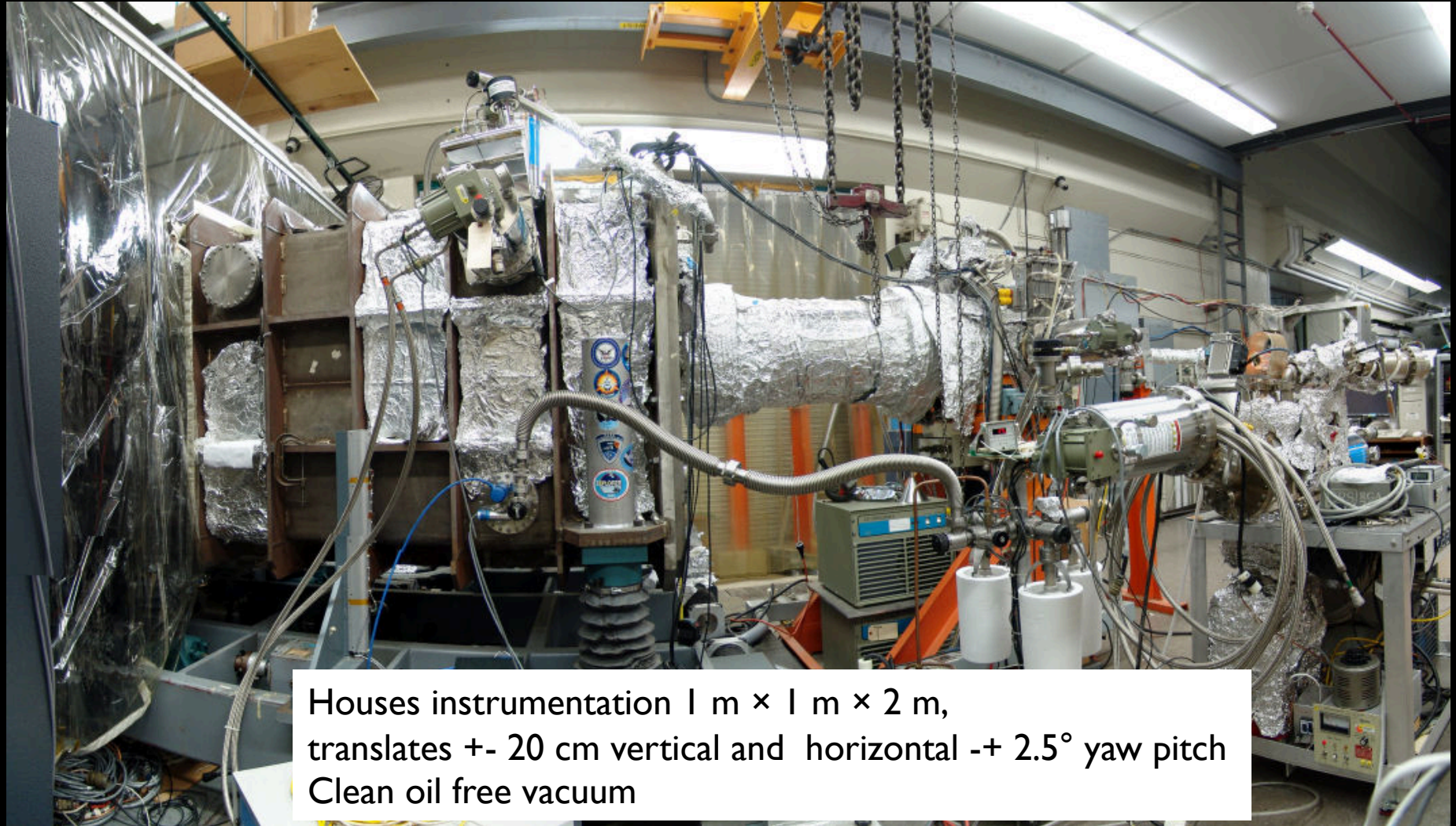
- Undispersed synchrotron radiation and instrument aperture are used as a standard of irradiance.
- Class 10,000 clean room access to large chamber.
- Calibrations provided from 2 nm to 400 nm with uncertainty from 0.6% to < 0.1%



EVE (Extreme Ultraviolet Variability Experiment) of NASA's Solar Dynamics Observatory (SDO) Mission prepared for calibration

Continuous calibration of twin-instruments using rocket underflights

BL-2: Large chamber and clean room



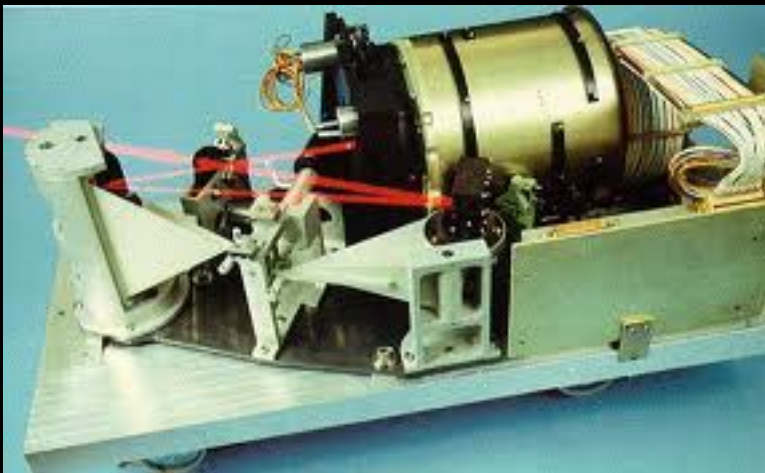
Houses instrumentation 1 m × 1 m × 2 m,
translates +/- 20 cm vertical and horizontal +/- 2.5° yaw pitch
Clean oil free vacuum

BL-2: NASA Missions

- Since 1971 most of our spectrometer calibrations have been for NASA missions.
- These include sounding rocket, Space Shuttle cargo bay, and satellite experiments.
- Most experiments measure full-disk solar radiation.
- Several stellar missions have been calibrated.

BL-2: LASP SOLSTICE and NRL SUSIM

LASP SOLSTICE and NRL SUSIM were aboard the UARS satellite deployed from shuttle in 1991

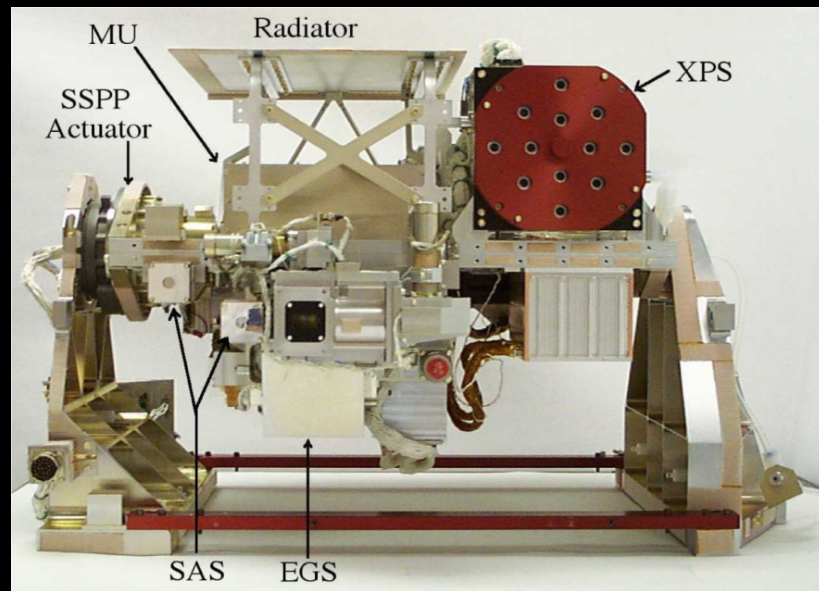


NRL SUSIM



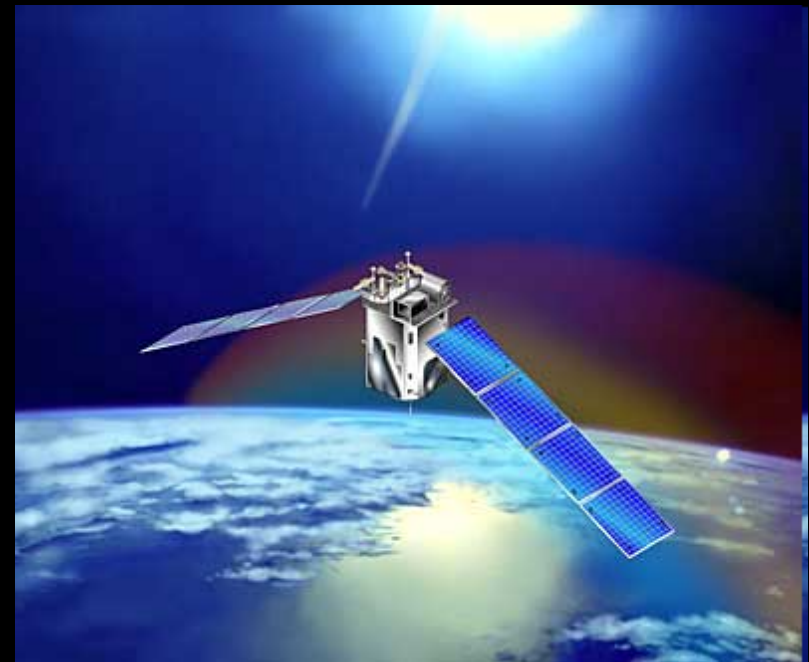
LASP SOLSTICE

BL-2: TIMED satellite



LASP Solar Extreme
Ultraviolet Experiment EUV
Grating Spectrometer aboard
the TIMED satellite
launched in 2001

Measuring the solar EUV
incident on the earth's
mesosphere and lower
thermosphere and
ionosphere where all vacuum
UV is absorbed

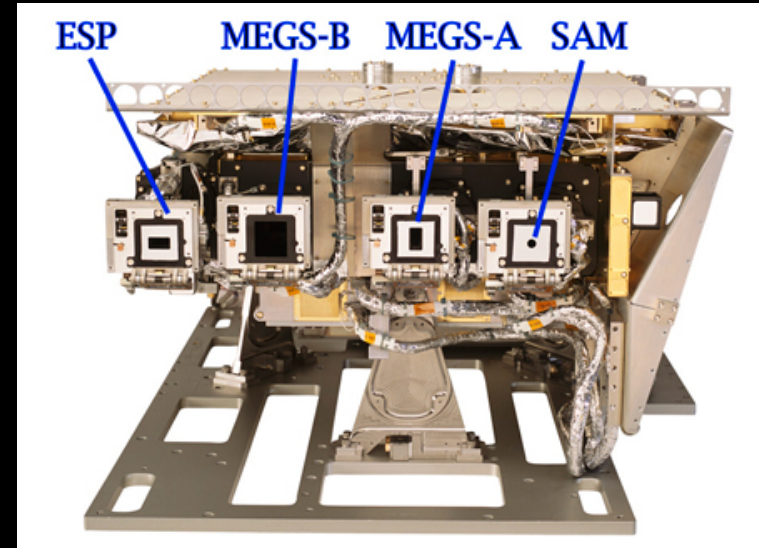


BL-2: LASP SOLSTICE A and SOLSTICE B



LASP SOLSTICE A and SOLSTICE B are monitoring solar UV radiation aboard the SORCE (SOLAR Radiation and Climate Experiment) satellite launched in 2003.

BL-2: LASP/USC Extreme UV Variability Experiment on SDO

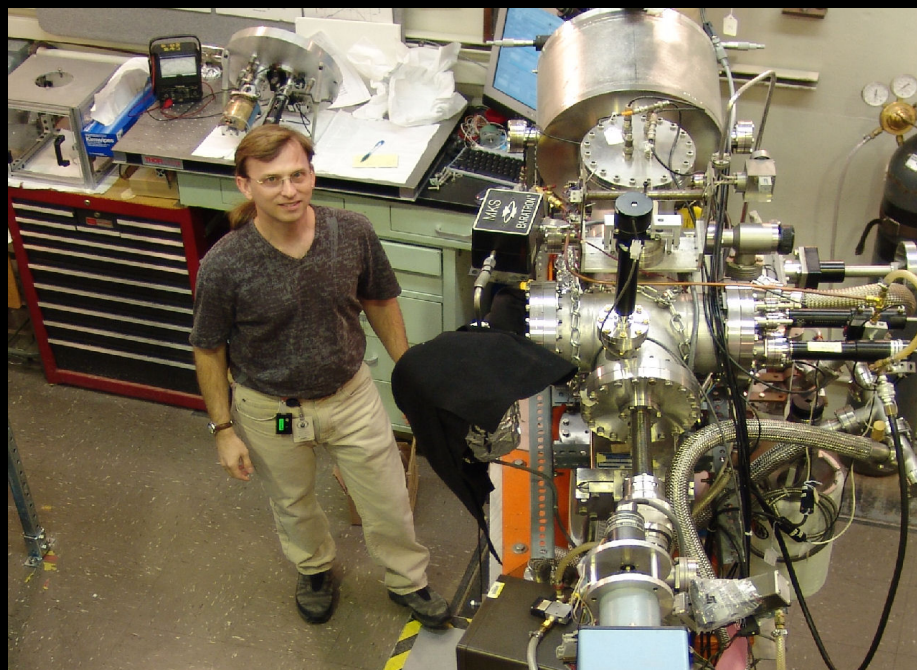
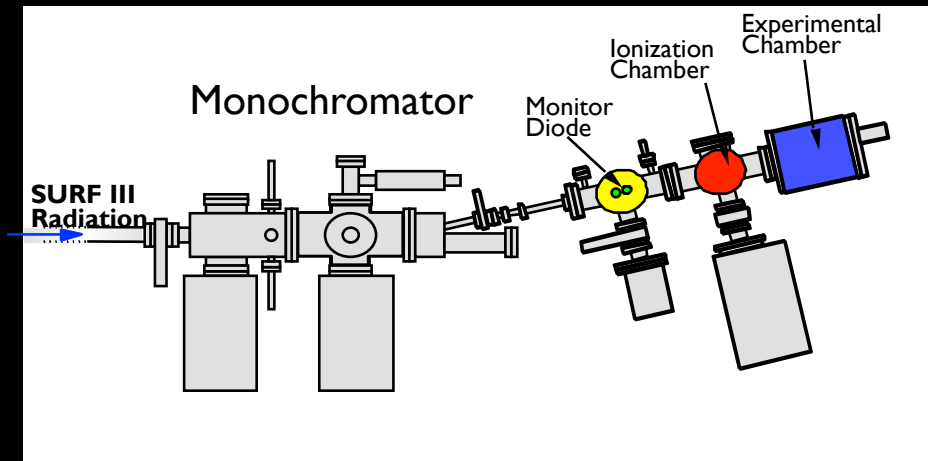


Studying EUV over various time scales relevant to space weather and its effect on communications and navigation

BL-2: Maintaining Satellite Calibrations

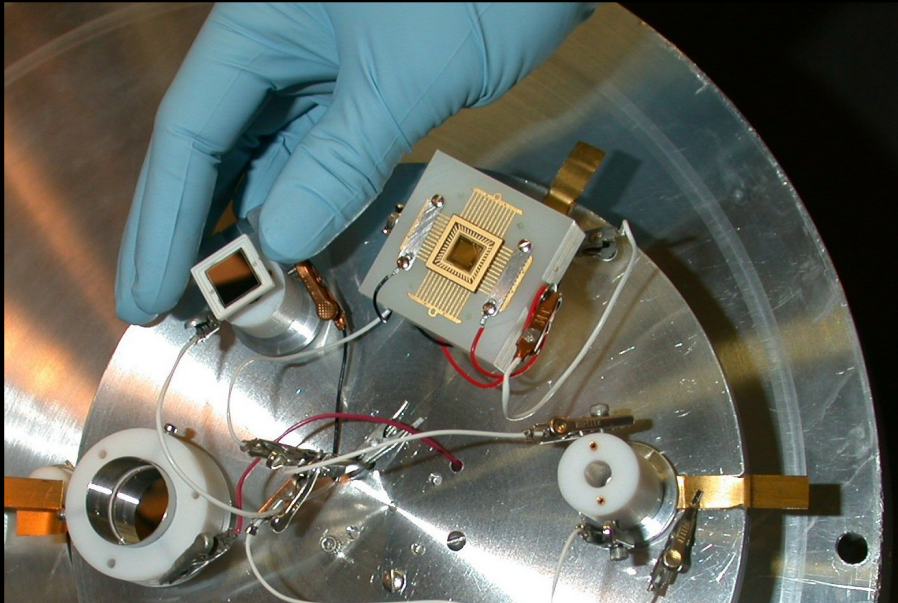
- SUSIM: multiple onboard D₂ lamps intercompared with SURF
- SOLSTICE: use stellar slits and measure ensemble of low variability stars
- Periodic sounding rocket underflights with similar instruments

BL-9: EUV Detector Calibrations



- Grazing incidence monochromator
- SURF used as continuum source from 5 nm to 50 nm
- Accuracy
 - Working standard
Photodiodes are calibrated by comparing them to a rare-gas ionization chamber: $2\sigma \approx 5\%$. (Not true if ACR is used on BL-7)
 - Transfer standards
Calibrated against a working standard of the same type: $2\sigma \approx 8\%$.
- Capabilities:
 - Photodetector Efficiency
 - Filter Transmission
 - End-to-End Calibration of Small Instruments
 - Low-Dose-Rate Radiation Hardness

SURF III/NIST Measurement Competences



- Detector efficiency
 - BL-4 ultraviolet, BL-7/BL-9 extreme-ultraviolet
- Filter transmission
 - BL-4 ultraviolet, BL-7/BL-9 extreme-ultraviolet
- Mirror reflectivity
 - BL-4 ultraviolet, BL-7 extreme-ultraviolet
- Whole-instrument efficiency (detector-based or source-based)
 - BL-2 extreme-ultraviolet to visible, BL-3 ultraviolet

Outline

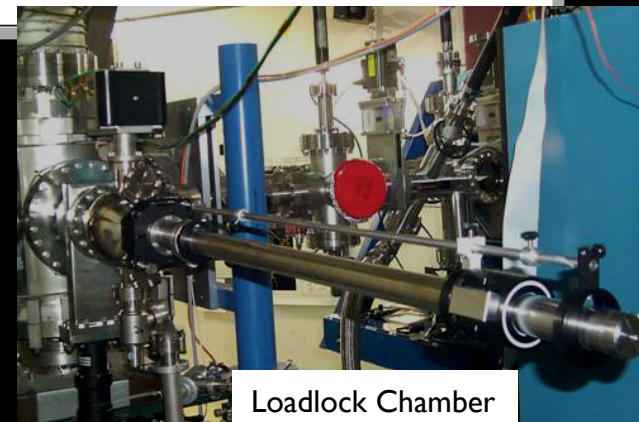
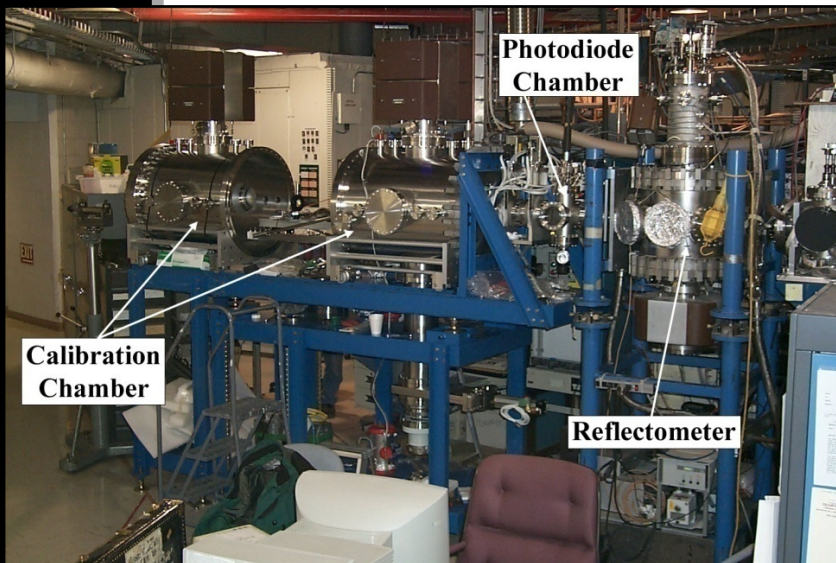
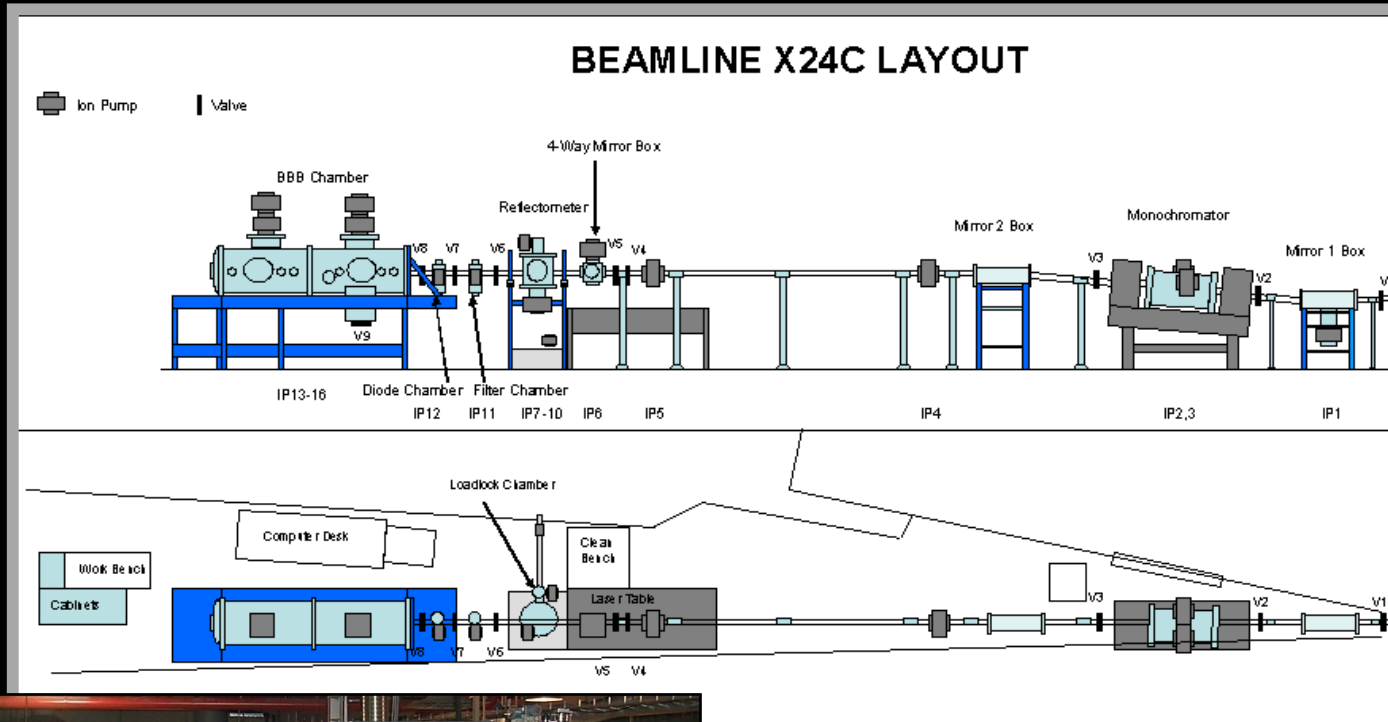
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Transfer of NRL's x24c to NIST

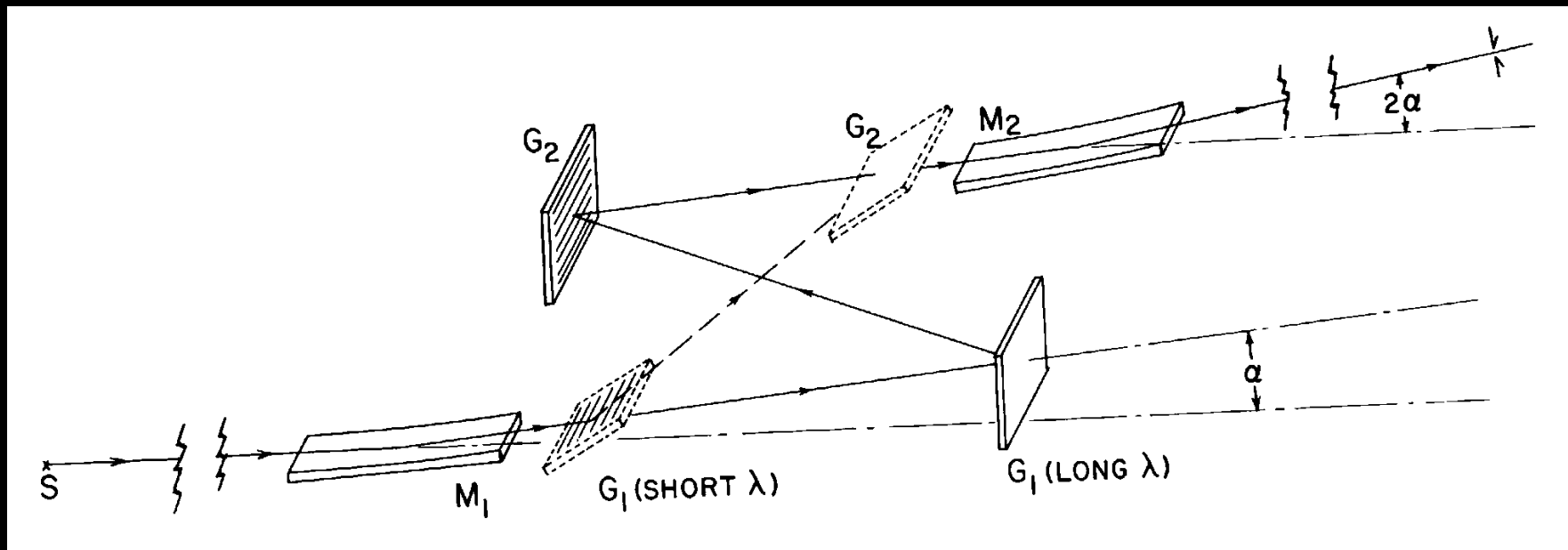


- NRL maintains beamline X24C
- Monochromator-based beamline with an absolute-cryogenic radiometer
 - Beamline covers 1 nm to 400 nm with a combination of grazing and normal incidence gratings (can use multilayers)
 - Several large chambers are available
- When NSLS II comes online in **2015** X24C will not be transferred

NSLS Beamline Layout and Chambers



Monochromator Optics



Capabilities of X24C Located at SURF III

- Enable cryogenic radiometry with 1% uncertainty by delivering at least $0.5 \mu\text{W} / 100 \text{ mA}$ and resolving power of at least 100 from 3.5 nm (354 eV) to 300 nm (4.1 eV).
 - Covers entire calibration range with state-of-the-art cryogenic radiometry.
 - Extends wavelength range: current limits are 5 nm (250 eV) and 254 nm (4.9 eV).
 - Usable over broader wavelength range at somewhat larger uncertainty, including the entire water window between 2.3 nm (O-K; 540 eV) and 4.4 nm (C-K; 280 eV).
 - Fills gap between 92 nm and 116 nm where there is no current detector standard.
- Establish EUV calibration center for detectors and space research instrumentation in a single synchrotron beamline facility at NIST.
- Complements existing source-based radiometric capability at SURF III BL-2